

Notice of References Cited	Application/Control No. 10/655,767	Applicant(s)/Patent Under Reexamination YAO ET AL.	
	Examiner Derek L Dupuis	Art Unit 2883	Page 1 of 1

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*	B	US-6,604,685 B1	08-2003	Norton, Stephen P.	235/492
*	C	US-2001/0024551 A1	09-2001	Yonemura et al.	385/88
*	D	US-5,256,865	10-1993	Wike et al.	235/462.15
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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